

Magnetic tunnel junctions with a Li-substituted MgAl_2O_4 barrier

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Magnetic tunnel junctions (MTJs) with an MgAl_2O_4 spinel barrier and bcc-based ferromagnetic electrodes, e.g., Fe and Co_2FeAl , have been demonstrated to show large tunnel magnetoresistance (TMR) ratios owing to the good lattice matching of MgAl_2O_4 with the bcc electrodes [1,2]. For future applications of spinel-based MTJs, it will be effective to tune various barrier properties through substituting the constituent elements in a spinel oxide barrier. In this study, we choose Li as a substitution element in MgAl_2O_4 because it is the lightest alkali metal in the periodic table and it is able to form stable spinel oxides due to its small ionic radius (i.e. $\text{Li}_{0.5}\text{Al}_{2.5}\text{O}_5$). A Li-substituted MgAl_2O_4 ($\text{Li}_x\text{Mg}_{1-2x}\text{Al}_{2+x}\text{O}_4$) insulator was first investigated as a material for the use in Li-ion batteries [3]. In this study, we fabricated a Li-substituted MgAl_2O_4 barrier by oxidation of Mg/Li-Al alloy bilayers for a new coherent-tunneling MTJs [4].

MTJ multilayers were fabricated by magnetron sputtering on an $\text{MgO}(001)$ substrate. The stacking structure is: MgO substrate//Cr (40)/Fe (30)/Mg (0.45)/ $\text{Li}_{11}\text{Al}_{89}$ (1.05)/plasma oxidation and annealing at T_{Barrier} /Fe (6)/IrMn (12)/Ru (20), (thickness in nm). The barrier composition was estimated to be $\text{Li}_{0.25}\text{Mg}_{0.72}\text{Al}_{2.03}\text{O}_4$. Crystalline structures of the whole multilayers were investigated using X-ray diffraction (XRD). Magneto-transport properties were characterized using current-in-plane tunneling (CIPT) and dc four probe method.

The XRD analysis confirmed an epitaxial growth with (001) orientation for both the bottom- and top- Fe electrodes, revealing an epitaxial growth of the Li-substituted MgAl_2O_4 barrier. The TMR ratio up to 120% at room temperature (RT) was observed for $T_{\text{Barrier}} = 250^\circ\text{C}$. The typical TMR curve for a microfabricated MTJ is shown in Fig. 1. We also found a weak temperature dependence of the resistance for the parallel magnetization state and local minima in the differential conductance spectrum, suggesting the occurrence of coherent

tunneling through the barrier. Therefore, Li-based spinel oxides are promising materials for MTJ applications. This study was partly supported by JSPS KAKENHI 16H06332&16H03852, and the ImPACT Program of Council for Science, Technology and Innovation, Japan.

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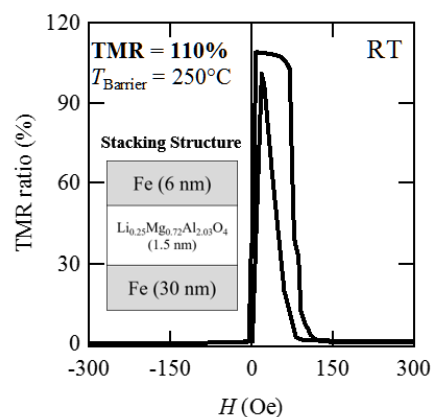


Fig. 1. TMR curve at RT for a microfabricated MTJ. Inset shows the stack structure.